

1/14/2005

①

FORM PTO-1449 (MODIFIED) LIST OF PATENTS AND PUBLICATIONS FOR APPLICANT'S INFORMATION DISCLOSURE STATEMENT (Use several sheets if necessary)	ATTY DOCKET NO. 67,200-1114	SERIAL NO. 101677155 To Be Assigned
	APPLICANT Hui-Chuan Hung	
	FILING DATE Filed Herewith	GROUP Unknown 2829

REFERENCE DESIGNATION U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NO.	DATE	NAME	CLASS	SUB CLASS	FILING DATE
EL	AA	6,462,814B1	10/2002	Lo			
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						

FOREIGN PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NO.	DATE	COUNTRY	CLASS	SUB CLASS	TRANSLATION YES/NO
	AK						
	AL						
	AM						
	AN						

OTHER ART (including Author, Title, Date, pertinent pages, etc.)

EL	AO	Bruce et al, "Soft Devect Localization (SDL) on ICs", Proc. 28 th Int. Symp. for Testing and Failure Analysis, 3-7 Nov. 2002, Phoenix, AZ, pp. 21-27
	AP	

EXAMINER Emily Chan DATE CONSIDERED 1/16/07

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to application.

11/14/15

2

FORM PTO-1449 (MODIFIED) LIST OF PATENTS AND PUBLICATIONS FOR APPLICANT'S INFORMATION DISCLOSURE STATEMENT (Use several sheets if necessary)	ATTY DOCKET NO. 67,200-1114	SERIAL NO. 10/677155 <u>To Be Assigned</u>
	APPLICANT Hui-Chuan Hung	
	FILING DATE Filed Herewith	GROUP Unknown

REFERENCE DESIGNATION U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NO.	DATE	NAME	CLASS	SUB CLASS	FILING DATE
DN	AA	6,462,814B1	10/2002	Lo			
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						

FOREIGN PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NO.	DATE	COUNTRY	CLASS	SUB CLASS	TRANSLATION YES/NO
	AK						
	AL						
	AM						
	AN						

OTHER ART (Including Author, Title, Date, pertinent pages, etc.)

<div style="display: flex; align-items: center;"> <div style="font-size: 2em; margin-right: 10px;"> </div> <div> AO Bruce et al, "Soft Devect Localization (SDL) on ICs", Proc. 28th Int. Symp. for Testing and Failure Analysis, 3-7 Nov. 2002, Phoenix, AZ, pp. 21-27 </div> </div>
AP

EXAMINER

Jimmy Nguyen

DATE CONSIDERED

1/7/05

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to application.